Substitute for form 1449/PTO				Complete if Known		
				Application Number	10/698,822-Conf. #1260	
SUPPLEMENTAL INFORMATION				Filing Date	October 30, 2003	
	DISCL	osi	JRE	First Named Inventor	Paul C. ALLEN	
STATEMENT BY APPLICANT				Art Unit	2873	
				Examiner Name	B. N. Thomas	
Sheet	1	of	1	Attorney Docket Number	0107262.00184US2	

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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	ВА	WO-00/02424	01-13-2000	LASER IMAGING SYSTEMS GMBH & CO. KG				
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	вс	WO-01/71655		LEXMARK INTERNATIONAL, INC.		П		

*EXAMINE: Initial reference considered, whether or not dation is a conformance with MEPE DOD. Once the through classifur it not in conformance and race considered. Include copy of the form which need communication to applicant. *CTBR X.O. Those application layer which are marked when a ringing saterity and to the CIb No. ser not supplied under 37 CFR 3.09(a)(3)(iii)) because that application was filled after June 30, 2003 or it evaluable in the PVV. Application control in the CIB Communication of the CIB Communicati

NON PATENT LITERATURE DOCUMENTS				
		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T2	
	CA	European Search Report issued for EP 04 784 504.5, dated January 28, 2008		
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner	Date	
Signature	Considered	

¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.